

Notice of References Cited	Application/Control No. 10/725,491	Applicant(s)/Patent Under Reexamination PARK, SEUNG-BIN	
	Examiner Yonel Beaulieu	Art Unit 3661	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,505,118	01-2003	Chowanic et al.	701/209
	B	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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